

Search Notes (continued)

Application/Control No.

10/617,129

Examiner

Meless N. Zewdu

Applicant(s)/Patent under
Reexamination

JESCHKE ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
370	277-283	11/26/2006	M.Z.
370	294-295	11/26/2006	M.Z.
370	310, 447	11/26/2006	M.Z.
370	312-314	11/26/2006	M.Z.
370	329-330	11/26/2006	M.Z.
370	341-350	11/26/2006	M.Z.
370	441-445	11/26/2006	M.Z.
370	480, 491	11/26/2006	M.Z.
370	522, 532	11/26/2006	M.Z.
370	537, 455	11/26/2006	M.Z.
370	458-462	11/26/2006	M.Z.
455	13.4, 71	11/26/2006	M.Z.
455	68-69	11/26/2006	M.Z.
455	71, 88	11/26/2006	M.Z.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search strategy and techniques include ilnventor, class-subclass and text.	11/26/2006	M.Z.
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT AND IBM-TDB).	11/26/2006	M.Z.
(field near8 (bit\$1 near7 indicator))	11/26/2006	M.Z.
(secondary near9 (common near7 (control near6 (physical near3 channel)))) or SCCPCH	11/26/2006	M.Z.
(indicat\$3 near9 (channel near5 combination))	11/26/2006	M.Z.
(field near9 (indicat\$3 near5 bit))	11/26/2006	M.Z.
(frame near5 slot\$1)	11/26/2006	M.Z.
Note: the aobve text hits were combined with other search hits.	11/26/2006	M.Z.

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455	161.2- 161.3	11/26/2006	M.Z.
455	403, 420	11/26/2006	M.Z.
455	434, 511	11/26/2006	M.Z.
455	515-517	11/26/2006	M.Z.
455	522, 525	11/26/2006	M.Z.

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